PRODUCT CHANGE NOTIFICATION PCN-000615

Date: 27APR2020

P1/2

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Cha	ange Details		
Part Number(s) Affected: Customer Part Number(s) Affected: N/A			
RClamp0524PATCT			

Description, Purpose and Effect of Change:

SEN

For the benefit of our customers, Semtech has qualified additional manufacturing capacity for the RClamp0524PATCT. A third assembly and test site, Semtech SCI USA, has been qualified to manufacture RClamp0524PATCT.

RClamp0524PA parts assembled and tested at Huatian and Diodes will continue to ship.

- a. Additional Assembly and Test Capacity Semtech SCI, Colorado Springs, CO USA
- b. Current POR Diodes Shanghai, China and Huatian Xian, China.

The land pattern remains unchanged.

In order to accommodate the third assembly site, minor POD changes were required. (See below)





PRODUCT CHANGE NOTIFICATION PCN-000615 Date: 27APR2020

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Change Classification	🖂 Major 🗌 Minor	Impact to Form, Fit, Function	🗌 Yes 🛛 No					
Impact to Data Sheet	🛛 Yes 🗌 No	New Revision or Date	⊠ N/A					
Impact to Performance, Characteristics or Reliability:								
 NO impact to per 	formance, characteristics	s; or reliability						
 NO change to the 	e land pattern.							
Minor POD chan	ges, shown above.							
Implementation Date	1AUG2020	Work Week	TBD					
Last Time Ship (LTS) Of unchanged product	Not Applicable Additional Capacity	Affecting Lot No. / Serial No. (SN)	N/A					
Sample Availability	Immediate	Qualification Report Availability	Included with Notification					
Supporting Document a. Product Qualifi b. Datasheet c. Test Summary	s for Change Validatior cation Report.	n/Attachments:						
	Issuing A	Authority						
Semtech Business Unit								
Semtech Contact Info:	Les Fang Yuen Semtech Corporation Sr. Eng Manager, QA 200 Flynn Road Camarillo, CA 93012 Email: Ifangyuen@semtech.com Phone: (949) 269-4443 [office]							
FOR FURTHER INFORMATION & WORLDWIDE SALES COVERAGE: <u>http://www.semtech.com/contact/index.html#support</u>								



Reliability Job Detail Report

	RCLAMP0524PA
Semtech Job#	7040
Accepted Date	09-10-2019
Job Type	New Device with un-qualified package and qualified process
Business Unit	Protection
Package Type	SMF2510P8
Package Lead	8
Assembly Designator	SCI
Master Process	PALM E
Fab Designator	Tower
Rel Job Status	Rel Testing Complete Passes All Requirements

Comment:

Qualification of RClamp0524PA SMF2510P8 Z-Ultra using Alpha WS9160-M7 Flux and Surfx Plasma

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Completed Tasks

Sub Lot #	Part		Lot	Assembly Lot	I	Date Code
1	RClamp0524PA		AER-6263	AER-6263	1	.937
Task#	Task Code	Sample Size		Criteria	Failures	Task On Actual
1	Data-Prep	None	None		0	09-19-2019
2	HTRB_Pre_Elect_150°C_RT24	105	Pass on Zero Fails		0	10-15-2019
3	HTRB_150°C_Real Time_0024	105	Pass on Zero Fails		0	10-18-2019
4	HTRB_Pre_Elect	105	Pass on Zero Fails		0	10-03-2019
5	BI_BD_Valid	105	Meet HTOL Schemat	ics	0	10-03-2019
6	HTRB_150°C_0072	105	Pass on Zero Fails		0	10-04-2019
7	HTRB_150°C _0408	105	Pass on Zero Fails		0	10-07-2019
8	HTS_Pre_Elect	77	Pass on Zero Fails		0	10-02-2019
9	HTS_0168	77	Pass on Zero Fails		0	10-02-2019
10	HTS_0500	77	Pass on Zero Fails		0	10-09-2019
11	HTS_1000	77	Pass on Zero Fails		0	10-23-2019
12	ROSE Clean/ Test	174	Pass on Zero Fails		0	09-20-2019
13	85°C/85%RH_N/Pre_Pre Elec	20	Pass with 0 fail		0	10-08-2019
14	85°C/85%RH_BD_Valid	20	Pass on Zero Fails		0	10-08-2019
15	85/85_120hr_On/Off	20	Pass on Zero Fails		0	10-08-2019
16	Pre_Conditioning_Level_1	NA	MSL 1		0	09-19-2019
17	Pre_Elect_Precond	154	Pass on Zero Fails		0	09-23-2019
18	Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails		0	09-23-2019
19	Precond_HTS_24hr	154	Pass on Zero Fails		0	09-23-2019
20	Precond_85/85_NoElec168hr	154	Pass on Zero Fails		0	09-24-2019
21	Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails		0	10-02-2019
22	T/C_Pre_Elect	77	Pass on Zero Fails		0	10-02-2019

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Task#	Task Code	Sample Size	Criteria	Failures	Task On Actual
23	T/C_wPre_0250	77	Pass on Zero Fails	0	10-02-2019
24	T/C_wPre_0500	77	Pass on Zero Fails	0	10-08-2019
25	T/C_wPre_1000	77	Pass on Zero Fails	0	10-14-2019
26	Cross_Section TC 1000 Cyc	5	Pass on Zero Fails	0	10-23-2019
27	85°C/85%RH_W/Pre_Pre Elec	77	Pass on Zero Fails	0	10-02-2019
28	85°C/85%RH_BD_Valid	105	Pass on Zero Fails	0	10-03-2019
29	85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	1	10-03-2019
30	85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	0	10-10-2019
31	85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	0	10-24-2019
32	Cross_Section 85°C/85%RH	5	Pass on Zero Fails	0	11-14-2019
33	CSAM Analysis	22	Pass on Zero Fails	0	11-06-2019
34	Precond_Temp_Cyc_5cyc	22	Pass on Zero Fails	0	11-07-2019
35	Precond_HTS_24hr	22	Pass on Zero Fails	0	11-07-2019
36	Precond_85/85_NoElec168hr	22	Pass on Zero Fails	0	11-08-2019
37	Precond_260°C_IR_Ref_Char	22	Pass on Zero Fails	0	11-15-2019
38	CSAM Analysis	22	Pass on Zero Fails	0	01-09-2020
39	Construct_Package	5 unique packaged devices minimum.	No Major Findings, Q&R to review construction analysis report.	0	08-09-2019
40	Pack_Clos	0	0	0	01-10-2020

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On Actual

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29	85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	0	10-24-2019
30	85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	0	10-31-2019
31	85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	0	11-14-2019
32	Cross_Section 85°C/85%RH	5	Pass on Zero Fails	0	12-05-2019
33	CSAM Analysis	22	Pass on Zero Fails	0	11-06-2019
34	Precond_Temp_Cyc_5cyc	22	Pass on Zero Fails	0	11-07-2019
35	Precond_HTS_24hr	22	Pass on Zero Fails	0	11-07-2019
36	Precond_85/85_NoElec168hr	22	Pass on Zero Fails	0	11-08-2019
37	Precond_260°C_IR_Ref_Char	22	Pass on Zero Fails	0	11-15-2019
38	CSAM Analysis	22	Pass on Zero Fails	0	01-10-2020
39	Pack_Clos	0	0	0	01-10-2020

Sub Lot #	Part	Lot	Assemb	ly Lot	Date Code
3	RClamp0524PA	AER-62	AER-62	65	1937
Task#	Task Code	Sample Size	Criteria	Failures	Task On Actual
1	Data-Prep	None	None	0	09-19-2019
2	HTRB_Pre_Elect_150°C_RT24	105	Pass on Zero Fails	0	10-23-2019
3	HTRB_150°C_Real Time_0024	105	Pass on Zero Fails	0	11-04-2019
4	HTRB_Pre_Elect	105	Pass on Zero Fails	0	10-04-2019
5	BI_BD_Valid	105	Meet HTOL Schematics	0	10-04-2019
6	HTRB_150°C_0072	105	Pass on Zero Fails	0	10-04-2019
7	HTRB_150°C _0408	105	Pass on Zero Fails	0	10-07-2019
8	HTS_Pre_Elect	77	Pass on Zero Fails	0	10-02-2019
9	HTS_0168	77	Pass on Zero Fails	0	10-02-2019
10	HTS_0500	77	Pass on Zero Fails	0	10-09-2019
11	HTS_1000	77	Pass on Zero Fails	0	10-23-2019
12	ROSE Clean/ Test	174	Pass on Zero Fails	0	09-20-2019
13	85°C/85%RH_N/Pre_Pre Elec	20	Pass with 0 fail	0	10-09-2019
14	85°C/85%RH_BD_Valid	20	Pass on Zero Fails	0	10-09-2019
15	85/85_120hr_On/Off	20	Pass on Zero Fails	0	10-09-2019
16	Pre_Conditioning_Level_1	NA	MSL 1	0	09-19-2019

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Task#	Task Code	Sample Size	Criteria	Failures	Task On Actual
17	Pre_Elect_Precond	154	Pass on Zero Fails	0	09-23-2019
18	Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	0	09-23-2019
19	Precond_HTS_24hr	154	Pass on Zero Fails	0	09-23-2019
20	Precond_85/85_NoElec168hr	154	Pass on Zero Fails	0	09-24-2019
21	Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	0	10-02-2019
22	T/C_Pre_Elect	77	Pass on Zero Fails	0	10-02-2019
23	T/C_wPre_0250	77	Pass on Zero Fails	0	10-02-2019
24	T/C_wPre_0500	77	Pass on Zero Fails	0	10-08-2019
25	T/C_wPre_1000	77	Pass on Zero Fails	0	10-14-2019
26	Cross_Section TC 1000 Cyc	5	Pass on Zero Fails	0	10-23-2019
27	85°C/85%RH_W/Pre_Pre Elec	77	Pass on Zero Fails	0	10-02-2019
28	85°C/85%RH_BD_Valid	77	Pass on Zero Fails	0	10-08-2019
29	85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	0	10-14-2019
30	85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	0	10-21-2019
31	85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	0	11-04-2019
32	Cross_Section 85°C/85%RH	5	Pass on Zero Fails	0	11-26-2019
33	CSAM Analysis	22	Pass on Zero Fails	0	11-06-2019
34	Precond_Temp_Cyc_5cyc	22	Pass on Zero Fails	0	11-07-2019
35	Precond_HTS_24hr	22	Pass on Zero Fails	0	11-07-2019
36	Precond_85/85_NoElec168hr	22	Pass on Zero Fails	0	11-08-2019
37	Precond_260°C_IR_Ref_Char	22	Pass on Zero Fails	0	11-15-2019
38	CSAM Analysis	22	Pass on Zero Fails	0	01-09-2020
39	Pack_Clos	0	0	0	01-10-2020

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RClamp0524PA Low Capacitance RailClamp® **4-Line Surge and ESD Protection**

PROTECTION PRODUCTS

Description

RailClamp® TVS arrays are ultra low capacitance ESD protection devices designed to protect high speed data interfaces. This series has been specifically designed to protect sensitive components which are connected to high-speed data and transmission lines from overvoltage caused by ESD (electrostatic discharge), CDE (Cable Discharge Events), and EFT (electrical fast transients).

RClamp0524PA has a typical capacitance of only 0.3 pF between I/O pins. ESD characteristics are highlighted by high ESD withstand voltage (±12kV per IEC 61000-4-2), each device will protect four lines operating at 5 volts.

RClamp0524PA is in a DFN 10 Lead package. The leads are finished with lead-free NiPdAu. The flow-through package design simplifies PCB layout.

Features

- Transient Protection to
 - IEC 61000-4-2 (ESD) ±17 kV (Air), ±12kV (Contact) ٠
 - ٠ IEC 61000-4-4 (EFT) 40A (5/50ns)
 - IEC 61000-4-5 (Lightning) 5A (8/20µs) ٠
- Protects four High-Speed Data Lines
- Package design optimized for high speed lines •
- Working voltage: 5V •
- Low clamping voltage
- Low capacitance: 0.3 pF typical (I/O to I/O)
- Solid-State Silicon-Avalanche Technology •

Mechanical Characteristics

- Package: DFN 10-Lead •
- Pb-Free, Halogen Free, RoHS/WEEE Compliant .
- Lead Finish: NiPdAu
- Marking : Marking Code + Date Code
- Packaging : Tape and Reel

Applications

- High Definition Multi-Media Interface (HDMI)
- Embedded Display Port (eDP)

Functional Schematic

- **Display Port**
- LVDS
- V-by-One

Nominal Dimension



Device Schematic

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🔿 Pin5

Absolute Maximum Rating

Rating	Symbol	Value	Units
Peak Pulse Current (tp = $8/20\mu s$)	I _{PP}	5	A
ESD per IEC 61000-4-2 (Contact) ⁽¹⁾ ESD per IEC 61000-4-2 (Air) ⁽¹⁾	V _{ESD}	±12 ±17	kV
Operating Temperature	T _{OP}	-55 to +125	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	Any I/O pin to GND			5	V
Reverse Breakdown Voltage	V _{BR}	$I_t = 1$ mA, Any I/O pin to GND	6			V
Reverse Leakage Current	l _R	$V_{RWM} = 5V$			1	μA
Clamping Voltage	V _c	I _{pp} = 1A, tp = 8/20μs, Any I/O pin to GND			15	V
FCD Clamping Valtage ⁽²⁾		I _{pp} = 4A, tp = 0.2/100ns (TLP) Any I/O pin to GND		10.8		N
ESD Clamping Voltage ⁽²⁾ V _c		$I_{pp} = 16A$, tp = 0.2/100ns (TLP) Any I/O pin to GND		13.0		V
lunction Conscitance	6	V _R =0V, f=1MHz Any I/O pin to GND			0.8	
Junction Capacitance	C	V _R =0V, f=1MHz Between I/O pins		0.30	0.40	рF

Notes:

(1) ESD gun return path connected to Ground Reference Plane (GRP)

(2) Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, ITLP and VTLP averaging window: t1 = 70ns to t2 = 90ns.

(3) Dynamic resistance calculated from ${\rm I}_{\rm _{TLP}}$ = 4A to ${\rm I}_{\rm _{TLP}}$ = 16A

Typical Characteristics

Non-Repetitive Peak Pulse Power vs. Pulse Time



ESD Clamping (+8kV Contact per IEC 61000-4-2)



TLP Characteristic (Positive Pulse)





ESD Clamping (-8kV Contact per IEC 61000-4-2)







8/20us Surge Clamping Characteristic

RClamp0524PA Final Datasheet Revision Date

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Typical Characteristics

Capacitance vs. Reverse Voltage





Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to ensure reliable solder joint. The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 2. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application. Semtech's recommended mounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

Stencil design is one of the key factors which will determine the volume of solder paste which is deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where: L = Aperture Length W = Aperture Width T = Stencil Thickness

Semtech recommends a stencil thickness of 0.100mm - 0.125mm for this device. The stencil should be laser cut with electro-polished finish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. Due to the small aperture size, a solder paste with Type 4 or smaller particles is recommended. Assuming a 125um thick stencil, the aperture dimensions shown will yield an area ratio of 0.72 for the small pads and 1.25 for the large.



Table 2 - Recommended Assembly Guidelines				
Assembly Parameter	Recommendation			
Solder Stencil Design	Laser Cut, Electro-Polished			
Aperture Shape	Rectangular			
Solder Stencil Thickness	0.100mm (0.004″) -			
	0.125mm (0.005")			
Solder Paste Type	Type 4 size sphere or smaller			
Solder Reflow Profile	Per JEDEC J-STD-020			
PCB Solder pad Design	Non-Solder Mask Defined			
PCB Pad Finish	OSP or NiAu			

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Applications Information

Layout Guidelines for Optimum ESD Protection

Good circuit board layout is critical not only for signal integrity, but also for effective suppression of ESD induced transients. For optimum ESD protection, the following guidelines are recommended:

- Place the device as close to the connector as possible. This practice restricts ESD coupling into adjacent traces and reduces parasitic inductance.
- The ESD transient return path to ground should be kept as short as possible. Whenever possible, use multiple micro vias connected directly from the device ground pad to the ground plane.
- Avoid running critical signals near board edges.



Figure 4. HDMI 1.4 Application using RClamp0524PA

Outline Drawing - DFN 2.5 x 1.0 x 0.55mm 10 Lead





This device is available with two package outline drawings. Both are compatible with the recommended land pattern. Semtech reserves the right to ship either POD. Please review dimensions of each to guarantee either will work in your design.

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Land Pattern - DFN 2.5 x 1.0mm 10 Lead



Marking Code



Notes: Dot indicates pin 1 location

Tape and Reel Specification



Ordering Information

Part Number	Qty per Reel	Reel Size	
RClamp0524PATCT	3,000	7″	

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RClamp0524PA Z-ultra Test Summary

Les 20APR2020.r0

r0 - Initial Release

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Test Summary



RClamp0524PA							POR	Z-Ultra
Parameter	Symbol	Conditions T = 25C	Units	Min	Тур	Max	Average	Average
Reverse Stand-Off Voltage	V _{RWM}		v			5		
Reverse Breakdown Voltage	V_{BR}	I _{BR} = 1mA, L-G	v	6			9.12	9.96
Reverse Leakage Current	I _R	V _{RWM} = 5V, L-G	nA			1000	1.05	0.087
Clamping Voltage	V _C	I _{PP} = 1.0A, L-G, tp = 8 / 20 uS	v			15	10.32	10.35
Junction Capacitance	CJ	V _R = 0V, f = 1MHz L-L	pF		0.3	0.4	0.29	0.3
	- 5	V _R = 0V, f = 1MHz L-G				0.8	0.61	0.6
Peak Pulse Current	lpp	tp = 8 / 20 uS	Α			5	11	6.2
ESD (IEC 61000-4-2)	+/- 12kV Contact						±12kV	±21kV
	+/- 17	kV Air	±30kV	±28kV				



Source Data: RC0524PA Z-ultra AER-6260 Characterization Review - Nadia Diwas 09/24/2019

4/27/2020

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